



General Description

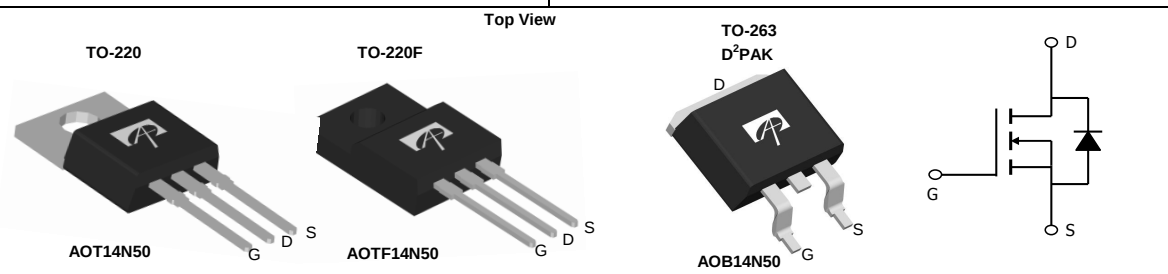
The AOT14N50 & AOB14N50 & AOTF14N50 have been fabricated using an advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular AC-DC applications. By providing low $R_{DS(on)}$, C_{iss} and C_{rss} along with guaranteed avalanche capability these parts can be adopted quickly into new and existing offline power supply designs.

For Halogen Free add "L" suffix to part number:
AOT14N50L & AOTF14N50L & AOB14N50L

Product Summary

V_{DS}	600V@150°C
I_D (at $V_{GS}=10V$)	14A
$R_{DS(on)}$ (at $V_{GS}=10V$)	< 0.38Ω

100% UIS Tested
100% R_g Tested



Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	AOT14N50/AOB14N50	AOTF14N50	Units
Drain-Source Voltage	V_{DS}	500		V
Gate-Source Voltage	V_{GS}	±30		V
Continuous Drain Current	$T_C=25^\circ\text{C}$	14	14*	A
	$T_C=100^\circ\text{C}$	11	11*	
Pulsed Drain Current ^C	I_{DM}	56		
Avalanche Current ^C	I_{AR}	6		A
Repetitive avalanche energy ^C	E_{AR}	540		mJ
Single plused avalanche energy ^G	E_{AS}	1080		mJ
Peak diode recovery dv/dt	dv/dt	5		V/ns
Power Dissipation ^B	$T_C=25^\circ\text{C}$	278	50	W
	Derate above 25°C	2.2	0.4	W/°C
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150		°C
Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds	T_L	300		°C

Thermal Characteristics

Parameter	Symbol	AOT14N50/AOB14N50	AOTF14N50	Units
Maximum Junction-to-Ambient ^{A,D}	$R_{\theta JA}$	65	65	°C/W
Maximum Case-to-sink ^A	$R_{\theta CS}$	0.5	--	°C/W
Maximum Junction-to-Case	$R_{\theta JC}$	0.45	2.5	°C/W

* Drain current limited by maximum junction temperature.

Electrical Characteristics (T_j=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V, T _j =25°C I _D =250μA, V _{GS} =0V, T _j =150°C	500			V
BV _{DSS} /ΔT _J	Zero Gate Voltage Drain Current	ID=250μA, VGS=0V		0.5		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =500V, V _{GS} =0V V _{DS} =400V, T _j =125°C			1 10	μA
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±30V			±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =5V I _D =250μA	3.3	4.2	4.5	V
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =7A		0.29	0.38	Ω
g _{FS}	Forward Transconductance	V _{DS} =40V, I _D =7A		20		S
V _{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V		0.71	1	V
I _S	Maximum Body-Diode Continuous Current				14	A
I _{SM}	Maximum Body-Diode Pulsed Current				56	A
DYNAMIC PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =25V, f=1MHz	1531	1914	2297	pF
C _{oss}	Output Capacitance		153	191	229	pF
C _{rss}	Reverse Transfer Capacitance		11	16	20	pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz	1.75	3.5	5.3	Ω
SWITCHING PARAMETERS						
Q _g	Total Gate Charge	V _{GS} =10V, V _{DS} =400V, I _D =14A		42.8	51	nC
Q _{gs}	Gate Source Charge			9.3	11	nC
Q _{gd}	Gate Drain Charge			20.3	24	nC
t _{D(on)}	Turn-On DelayTime	V _{GS} =10V, V _{DS} =250V, I _D =14A, R _G =25Ω		44	53	ns
t _r	Turn-On Rise Time			84	101	ns
t _{D(off)}	Turn-Off DelayTime			92	110	ns
t _f	Turn-Off Fall Time			50	60	ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =14A, dI/dt=100A/μs, V _{DS} =100V		289	347	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =14A, dI/dt=100A/μs, V _{DS} =100V		4.93	6	μC

A. The value of R_{θJA} is measured with the device in a still air environment with T_A=25°C.

B. The power dissipation P_D is based on T_{J(MAX)}=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150°C, Ratings are based on low frequency and duty cycles to keep initial T_J=25°C.

D. The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150°C. The SOA curve provides a single pulse rating.

G. L=60mH, I_{AS}=6A, V_{DD}=150V, R_G=25Ω, Starting T_j=25°C

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

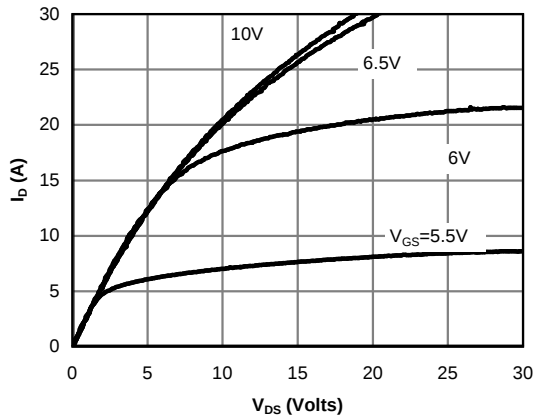


Fig 1: On-Region Characteristics

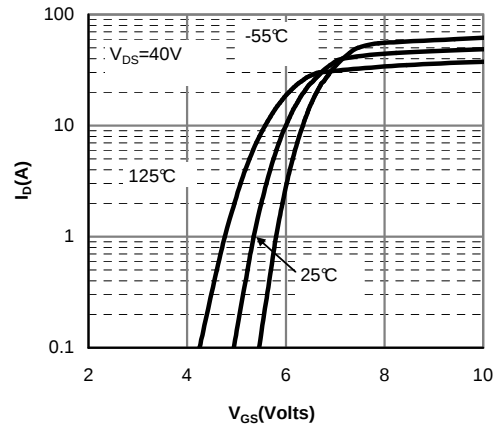


Figure 2: Transfer Characteristics

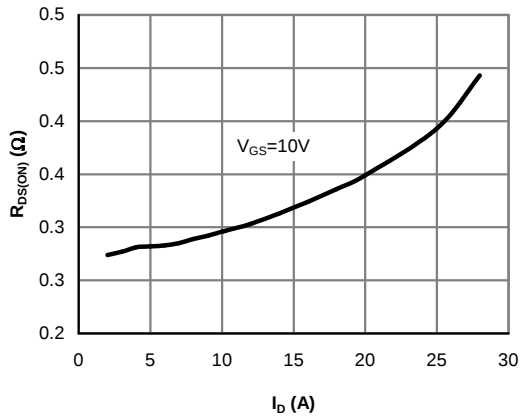


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

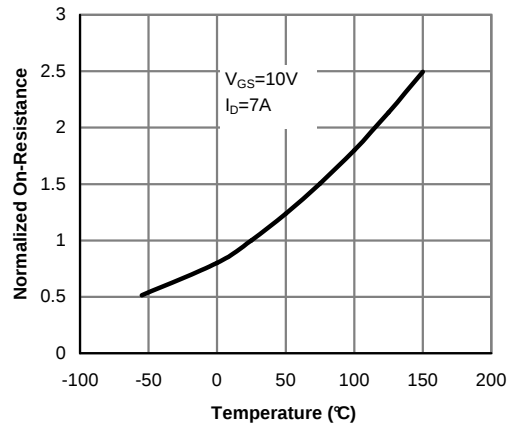


Figure 4: On-Resistance vs. Junction Temperature

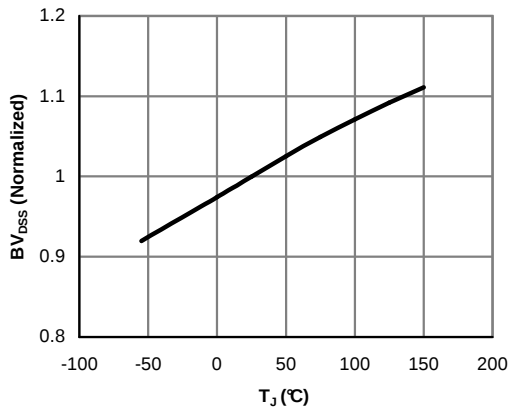


Figure 5: Break Down vs. Junction Temperature

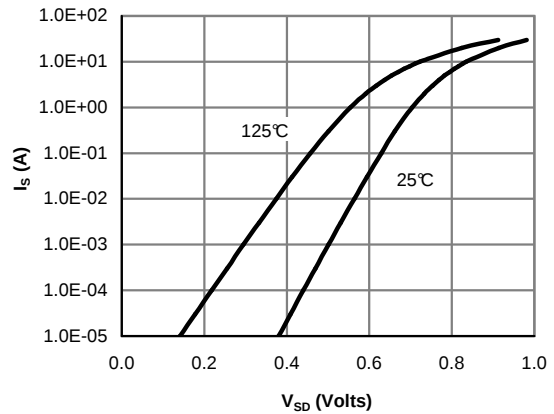


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

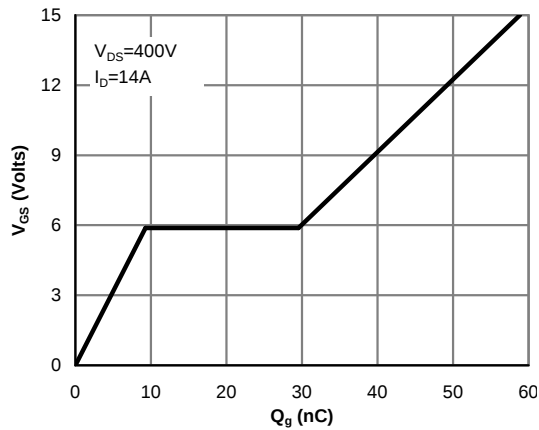


Figure 7: Gate-Charge Characteristics

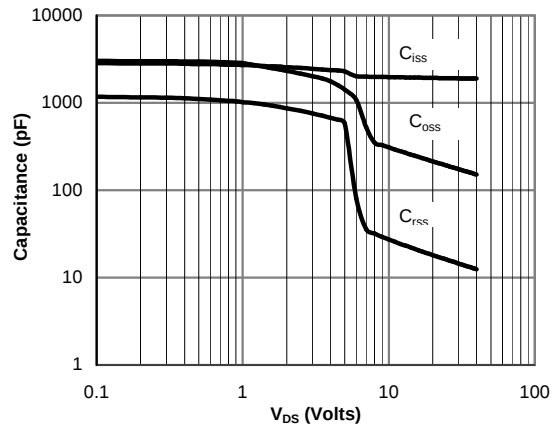


Figure 8: Capacitance Characteristics

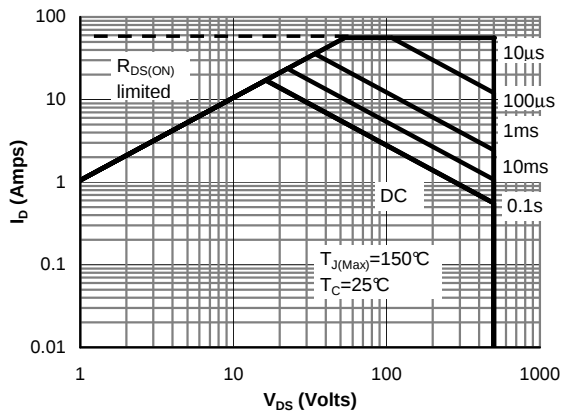


Figure 9: Maximum Forward Biased Safe Operating Area for AOT14N50/AOB14N50 (Note F)

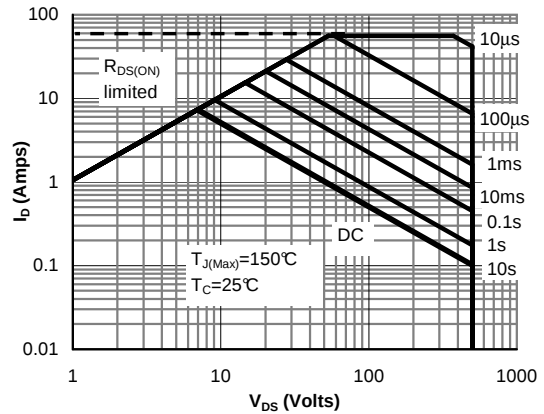


Figure 10: Maximum Forward Biased Safe Operating Area for AOTF14N50 (Note F)

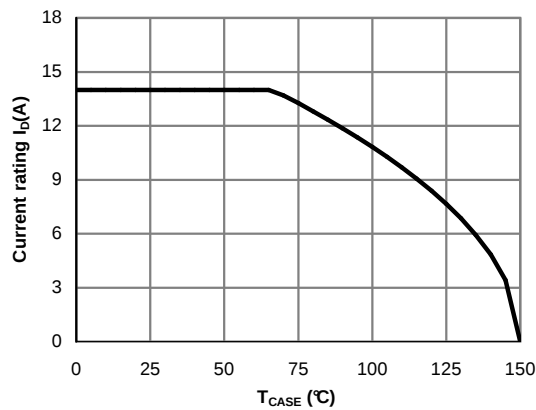


Figure 11: Current De-rating (Note B)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

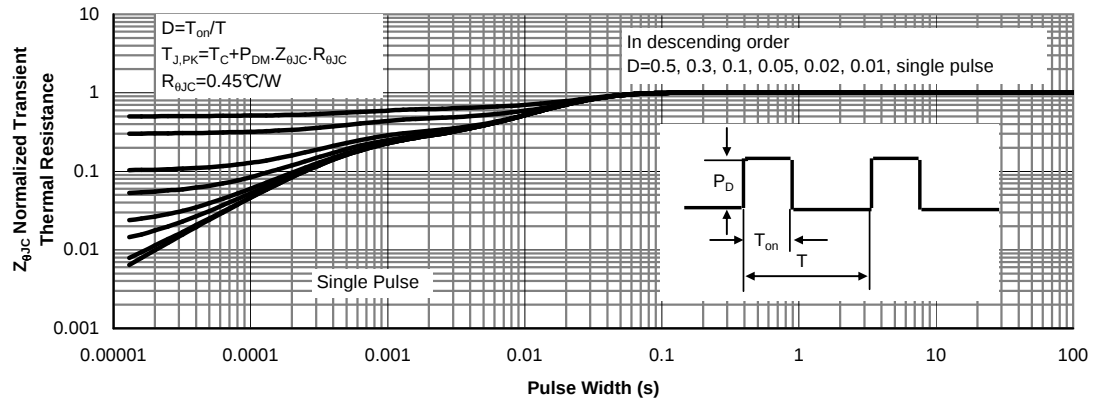


Figure 12: Normalized Maximum Transient Thermal Impedance for AOT14N50/AOB14N50 (Note F)

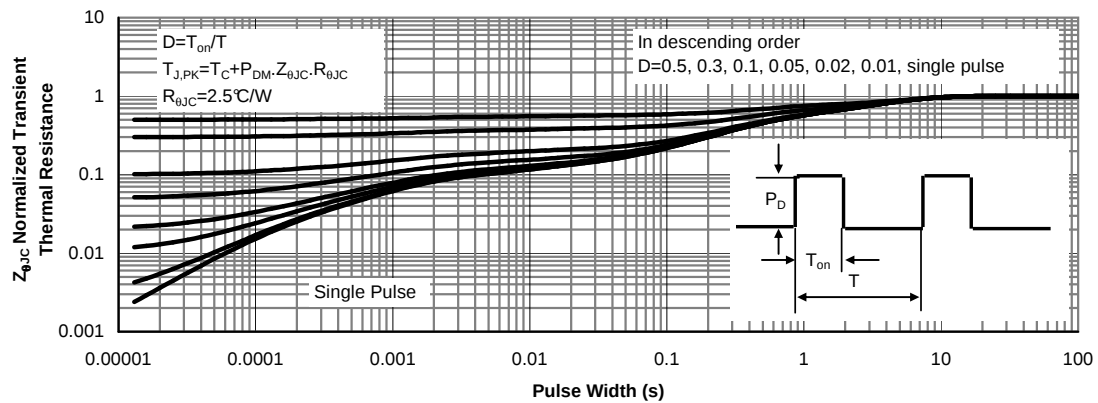
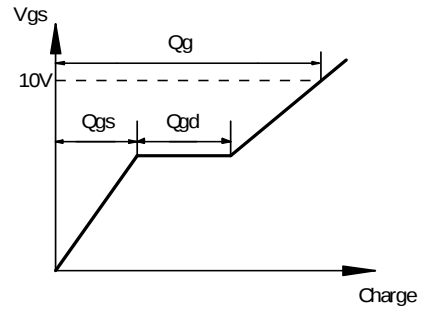
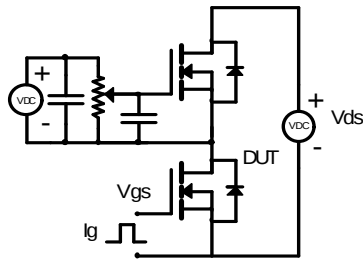
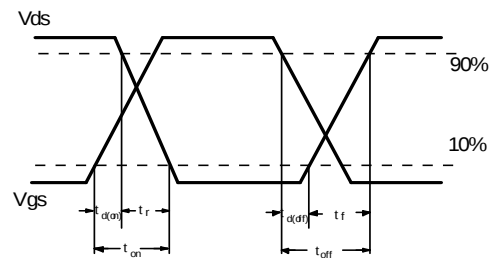
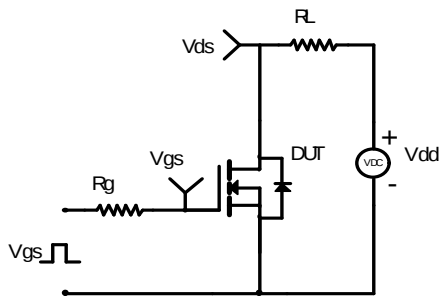


Figure 13: Normalized Maximum Transient Thermal Impedance for AOTF14N50 (Note F)

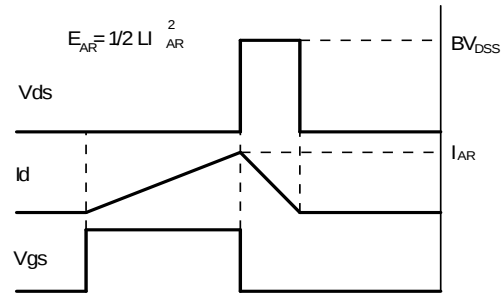
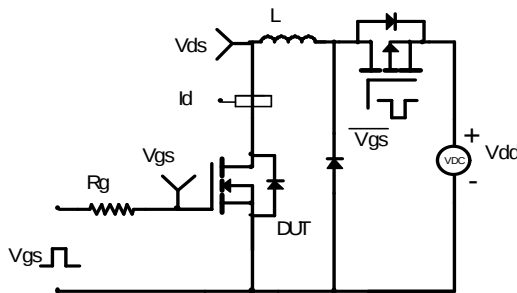
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

